

<b>Notice of References Cited</b>	Application/Control No. 10/593,242		Applicant(s)/Patent Under Reexamination KAMIYAMA ET AL.	
	Examiner Kevin S. Orwig		Art Unit 1611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,617,389 B1	09-2003	Delaunoy et al.	524/555
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004-83520A	03-2004	Japan	Terahara, et al.	A61K 31/48
	O					
	P					
	Q					
	R					
	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine translation of JP 2004-83520A
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	W	
	X	

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